

# UNISONIC TECHNOLOGIES CO., LTD

UF5N07 Power MOSFET

# 5A, 70V N-CHANNEL ENHANCEMENT MODE POWER MOSFET

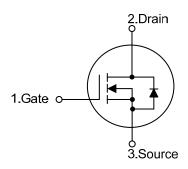
### **■** DESCRIPTION

The UTC **UF5N07** is a N-channel power MOSFET providing very low on-resistance. It has high efficiency and perfect cost-effectiveness. It can be generally applied in the commercial and industrial fields.

### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.2 $\Omega$  @  $V_{GS}$  =10V,  $I_D$  =2.5A
- \* Simple drive requirement

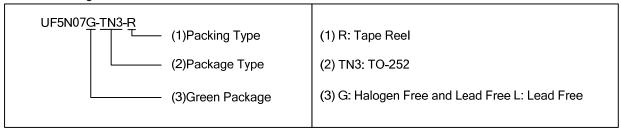
### ■ SYMBOL



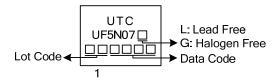
# ORDERING INFORMATION

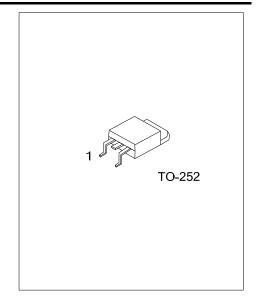
Ordering Number		Doolsono	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UF5N07L-TN3-R	UF5N07G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



### ■ MARKING





<u>www.unisonic.com.tw</u> 1 of 5

UF5N07 Power MOSFET

### ■ ABSOLUTE MAXIMUM RATING (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{ m DSS}$	70	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Drain Current	Continuous	$I_D$	5	Α
Drain Current	Pulsed (Note 2)	$I_{DM}$	15	Α
Avalanche Energy (Note 3)	Single Pulsed (Note 3)	E <sub>AS</sub>	11	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	18	V/ns
Power Dissipation		$P_D$	30	W
Junction Temperature		$T_J$	+150	°C
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 0.1 mH,  $I_{AS}$  = 15 A,  $V_{DD}$  = 50 V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C.
- 4.  $I_{SD} \le 5.0$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J = 25$ °C.

### **■ THERMAL DATA**

PARAMETER	SYMBOL	DATINGS	LINIT	
PARAMETER	STIVIBUL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	θ <sub>JC</sub>	4.2	°C/W	

### ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> =25°C, unless otherwise specified)

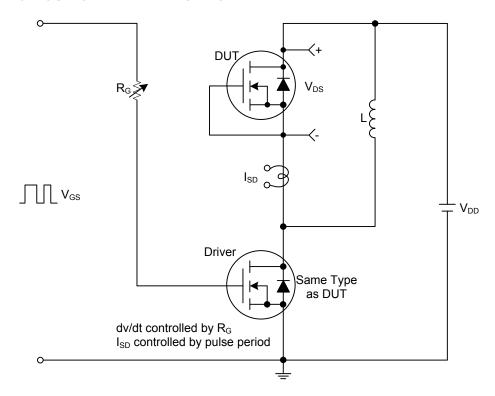
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250 \mu A$				V		
Drain-Source Leakage Current	$I_{DSS}$	$I_{DSS}$ $V_{DS} = 70V, V_{GS} = 0V$			10	μΑ		
Gate-Source Leakage Current	$I_{GSS}$	SSS V <sub>GS</sub> =±20V			±100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	2.0		4.0	V		
Drain to Source On-state Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.5A			0.2	Ω		
DYNAMIC PARAMETERS								
Input Capacitance	C <sub>ISS</sub>			250		pF		
Output Capacitance	Coss	$V_{DS}$ =25V, $V_{GS}$ =0V,f =1.0MHz		55		pF		
Reverse Transfer Capacitance	$C_{RSS}$			10		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)	$Q_G$	\/ -F6\/ \/ -10\/   -F 0A		11.3		nC		
Gate Source Charge	$Q_GS$	$V_{DS}$ =56V, $V_{GS}$ =10V, $I_{D}$ =5.0A, $I_{G}$ =1mA (Note 1, 2)		5.8		nC		
Gate Drain Charge	$Q_GD$	IG-IIIA (Note 1, 2)		1.7		nC		
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$			2.4		ns		
Turn-ON Rise Time	$t_R$	$V_{DD}$ =35V, $V_{GS}$ =10V, $I_{D}$ =5.0A,		15		ns		
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		3.4		ns		
Turn-OFF Fall-Time	$t_{F}$			2.7		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current	Is				5	Α		
Maximum Body-Diode Pulsed Current	$I_{SM}$				15	Α		
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =5.0A, V <sub>GS</sub> =0V			1.4	V		
Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =5.0A,V <sub>GS</sub> =0V,		40		ns		
Reverse Recovery Charge	$Q_{rr}$	dl/dt=100A/µs		110		nC		

Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

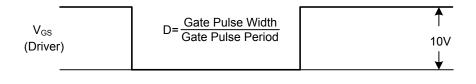
2. Essentially independent of operating ambient temperature.

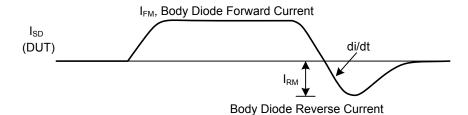
**UF5N07** 

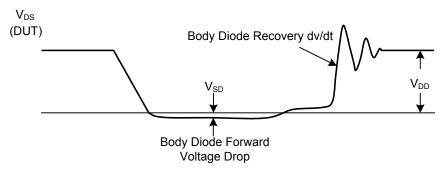
### ■ TEST CIRCUITS AND WAVEFORMS



## Peak Diode Recovery dv/dt Test Circuit





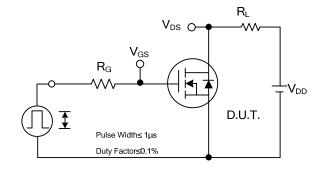


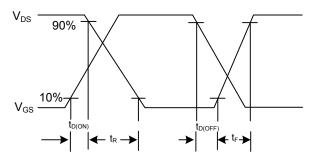
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

UF5N07 Power MOSFET

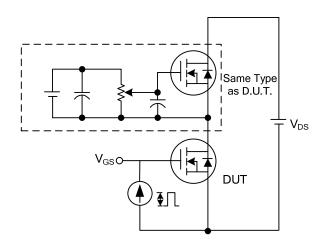
### ■ TEST CIRCUITS AND WAVEFORMS

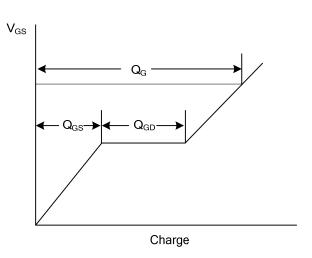




**Switching Test Circuit** 

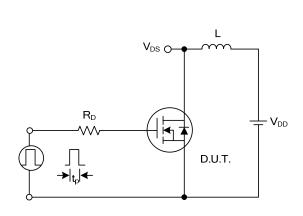
**Switching Waveforms** 

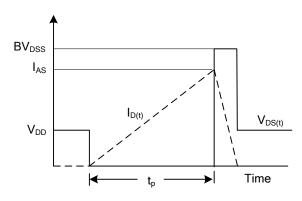




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 

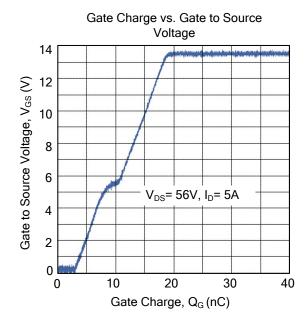


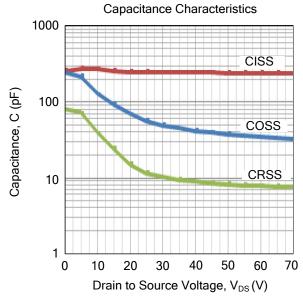


**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

### ■ TYPICAL CHARACTERISTICS





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